

TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

# TC74VHC165F, TC74VHC165FK

8-Bit Shift Register (P-IN, S-OUT)

The TC74VHC165 is an advanced high speed CMOS 8-BIT PARALLEL/SERIAL-IN, SERIAL-OUT SHIFT REGISTER fabricated with silicon gate  $\rm C^2MOS$  technology.

It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

It consists of parallel-in or serial-in, serial-out 8-bit shift register with a gated clock input. When the SHIFT/ $\overline{LOAD}$  input is held high, the serial data input is enabled and the eight frip-frops perform serial shifting with each clock pulse.

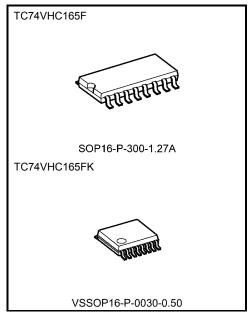
When the SHIFT/LOAD input is held low, the parallel data is loaded synchronously into the register at positive going transition of the clock pulse.

The CK-INH input should be shifted high only when the CK input is held high.

An Input protection circuit ensures that 0 to 5.5~V can be applied to the input pins without regard to the supply voltage. This device can be used to interface 5~V to 3~V systems and on two supply systems such as battery back up. This circuit prevents device destruction due to mismatched supply and input voltages.

#### **Features**

- High speed:  $f_{max} = 150 \text{ MHz}$  (typ.) at  $V_{CC} = 5 \text{ V}$
- Low power dissipation:  $ICC = 4 \mu A \text{ (max)}$  at Ta = 25 °C
- High noise immunity: V<sub>NIH</sub> = V<sub>NIL</sub> = 28% V<sub>CC</sub> (min)
- Power down protection is provided on all inputs.
- Balanced propagation delays: t<sub>p</sub>LH ≃ t<sub>p</sub>HL
- Wide operating voltage range:  $V_{CC}$  (opr) = 2 V to 5.5 V
- Pin and function compatible with 74ALS165



Weight

SOP16-P-300-1.27A : 0.18 g (typ.) VSSOP16-P-0030-0.50 : 0.02 g (typ.)

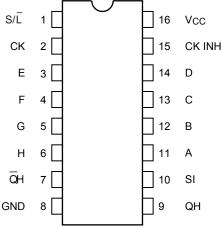
Start of commercial production 1992-05

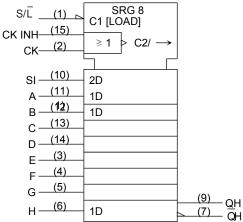
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#### **Pin Assignment**

# nent IEC Logic Symbol





#### **Truth Table**

Inputs						Internal Outputs		puts	
SHIFT/ LOAD	CK INH	CK	SERIAL IN	PARALLEL A······H	QA	QB	QH	QH	
L	Х	Х	Х	a·····h	а	b	h	h	
Н	L		Н	Х	Н	QAn	QGn	$\overline{\overline{Q}}G_n$	
Н	L		L	Х	L	L QA <sub>n</sub>		$\overline{\overline{Q}}G_n$	
Н		L	Н	Х	Н	QAn	QGn	$\overline{Q}G_n$	
Н		L	L	Х	L	QAn	QGn	$\overline{Q}G_n$	
Н	Х	Н	Х	Х	No Change				
Н	Н	Х	Х	Х	No Change				

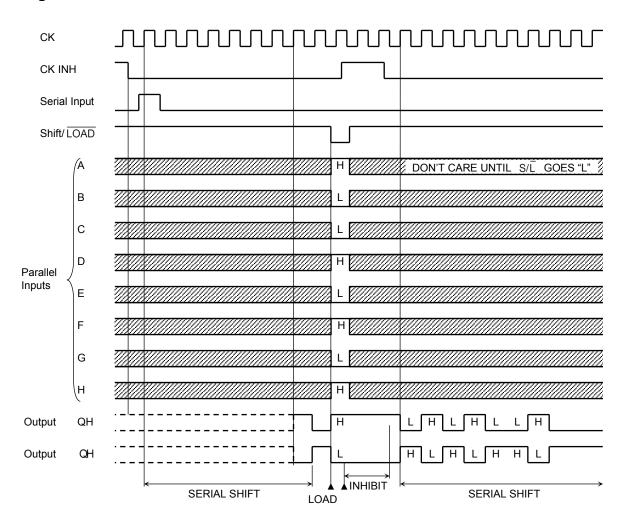
X: Don't care

a·····h: The level of steady state input voltage at inputs A through H respectively

QAn to QGn: The level of QA to QG, respectively, before the most recent positive transition of the CK.

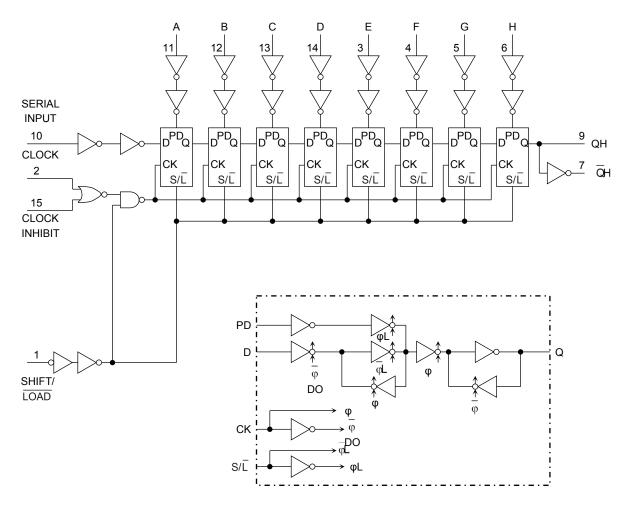


### **Timing Chart**





#### **System Diagram**



#### **Absolute Maximum Ratings (Note)**

Characteristics	Symbol	Rating	Unit
Supply voltage range	Vcc	−0.5 to 7.0	V
DC input voltage	VIN	−0.5 to 7.0	V
DC output voltage	Vout	-0.5 to V <sub>CC</sub> $+0.5$	V
Input diode current	lıĸ	-20	mA
Output diode current	lok	±20	mA
DC output current	lout	±25	mA
DC Vcc/ground current	Icc	±50	mA
Power dissipation	PD	180	mW
Storage temperature	T <sub>stg</sub>	−65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).



# **Operating Ranges (Note)**

Characteristics	Symbol	mbol Rating	
Supply voltage	Vcc	2.0 to 5.5	V
Input voltage	VIN	0 to 5.5	V
Output voltage	Vout	0 to Vcc	V
Operating temperature	Topr	−40 to 85	°C
Input rise and fall time	dt/dv	0 to 100 (V <sub>CC</sub> = $3.3 \pm 0.3$ V) 0 to 20 (V <sub>CC</sub> = $5 \pm 0.5$ V)	ns/V

Note: The operating ranges must be maintained to ensure the normal operation of the device.

Unused inputs must be tied to either VCC or GND.

#### **Electrical Characteristics**

#### **DC Characteristics**

Characteristics Symbol		Test Condition		Ta = 25°C			Ta = -40 to 85°C		Unit	
	, , ,				Min	Тур.	Max	Min	Max	
High-level input voltage	ViH	_		2.0 3.0 to 5.5	1.50 V <sub>CC</sub> × 0.7	1 1	_	1.50 V <sub>CC</sub> × 0.7	1 1	٧
Low-level input voltage	V <sub>IL</sub>	_		2.0 3.0 to 5.5		1 1	0.50 V <sub>CC</sub> × 0.3	1 1	0.50 V <sub>CC</sub> × 0.3	٧
High-level output VOH	VIN = VIH or VIL	$I_{OH} = -50 \mu A$ $I_{OH} = -4 \text{ mA}$	2.0 3.0 4.5 3.0	1.9 2.9 4.4 2.58	2.0 3.0 4.5	_ _ _	1.9 2.9 4.4 2.48		>	
Low-level output	Vol	DL VIN = VIH or VIL	$IOH = -8 \text{ mA}$ $IOL = 50  \mu\text{A}$	4.5 2.0 3.0 4.5	3.94	0.0 0.0 0.0	0.1 0.1 0.1	3.80 — — —	0.1 0.1 0.1	V
voltage	= VIH		I <sub>OL</sub> = 4 mA I <sub>OL</sub> = 8 mA	3.0 4.5	_ _	_ _	0.36 0.36	_ _	0.44 0.44	
Input leakage current	I <sub>IN</sub>	V <sub>IN</sub> = 5.5 V or GND		0 to 5.5	_	_	±0.1	_	±1.0	μА
Quiescent supply current	Icc	V <sub>IN</sub> = V <sub>CC</sub> or GND		5.5	_	_	4.0	_	40.0	μА



# Timing Requirements (input: $t_r = t_f = 3$ ns)

Characteristics	Symbol	Test Condition	Test Condition		25°C	Ta = -40 to 85°C	Unit
		\		Тур.	Limit	Limit	
Minimum pulse width (CK, CK INH)	t <sub>w (L)</sub>	_	$3.3\pm0.3\\5.0\pm0.5$	_ _	6.0 4.0	7.0 4.0	ns
Minimum pulse width	t <sub>W</sub> (L)	_	$3.3\pm0.3\\5.0\pm0.5$	_ _	7.5 5.0	9.0 6.0	ns
Minimum set-up time (PI- S/L)	ts	_	$3.3\pm0.3\\5.0\pm0.5$	_ _	7.5 5.0	8.5 5.0	ns
Minimum set-up time (SI-CK, CK INH)	ts	_	$3.3\pm0.3\\5.0\pm0.5$	_ _	5.0 4.0	6.0 4.0	ns
Minimum set-up time (S/L-CK, CK INH)	ts	_	$3.3\pm0.3\\5.0\pm0.5$	_ _	5.0 4.0	6.0 4.0	ns
Minimum hold time (PI- S/L )	th	_	$3.3\pm0.3\\5.0\pm0.5$	_ _	0.5 1.0	0.5 1.0	ns
Minimum hold time (SI-CK, CK INH)	th	_	$3.3\pm0.3\\5.0\pm0.5$	_ _	0.0 0.5	0.0 0.5	ns
Minimum hold time (S/L-CK, CK INH)	th	_	$3.3\pm0.3\\5.0\pm0.5$	_ _	0.0 0.5	0.0 0.5	ns
Minimum removal time (CK INH-CK) (CK-CK INH)	trem	_	$3.3 \pm 0.3$ $5.0 \pm 0.5$		5.0 3.5	5.0 3.5	ns



### AC Characteristics (input: $t_r = t_f = 3$ ns)

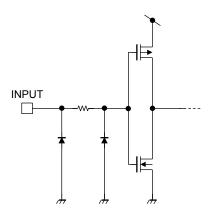
Characteristics	Symbol				Ta = 25°C			Ta = −40 to 85°C		Unit	
	<b>O</b> J <b>20</b> .			C <sub>L</sub> (pF)	Min	Тур.	Max	Min	Max	01	
	t <sub>pLH</sub>		3.3 ± 0.3	15	_	9.9	15.4	1.0	18.0		
Propagation delay time			3.3 ± 0.3	50	_	12.4	18.9	1.0	21.5	ns	
(CK, CK INH-QH, QH)	$t_{pHL}$	_	5.0 ± 0.5	15	_	6.6	9.9	1.0	11.5		
			5.0 ± 0.5	50	_	8.1	11.9	1.0	13.5		
			$3.3 \pm 0.3$	15	1	9.9	15.8	1.0	18.5	- ns	
Propagation delay time	t <sub>pLH</sub>	_	3.3 ± 0.3	50	_	12.4	19.3	1.0	22.0		
(S/L-QH, QH)	t <sub>pHL</sub>		5.0 ± 0.5	15	_	6.7	9.9	1.0	11.5		
				50	ı	8.2	11.9	1.0	13.5		
	tpLH tpHL		$3.3 \pm 0.3$	15	_	9.2	14.1	1.0	16.5	ns	
Propagation delay time		_		50	I	11.7	17.6	1.0	20.0		
(H-QH, QH)			5.0 ± 0.5	15	I	5.9	9.0	1.0	10.5		
				50	١	7.4	11.0	1.0	12.5		
				3.3 ± 0.3	15	65	85	_	55	١	
Maximum alask fraguanav	£		3.3 ± 0.3	50	60	105	_	50	_	MHz	
Maximum clock frequency	f <sub>max</sub> —	_	5.0 ± 0.5	15	110	150	_	90	_	IVI□∠	
			5.0 ± 0.5	50	95	130	_	85	_		
Input capacitance	CIN				1	4	10	_	10	pF	
Power dissipation capacitance	CPD			(Note)	_	50	_	_	_	pF	

Note: CPD is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

$$ICC (opr) = CPD \cdot VCC \cdot fIN + ICC$$

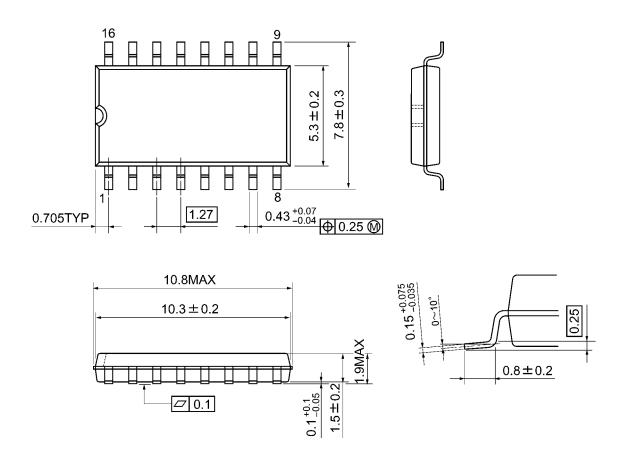
### **Input Equivalent Circuit**





#### **Package Dimensions**

SOP16-P-300-1.27A Unit: mm

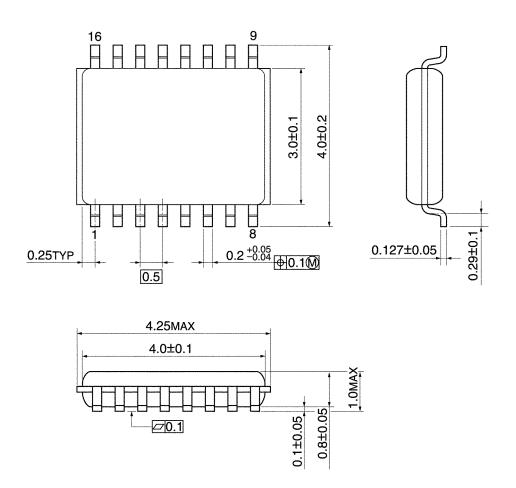


Weight: 0.18 g (typ.)



### **Package Dimensions**

VSSOP16-P-0030-0.50 Unit: mm



Weight: 0.02 g (typ.)



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